# NSS40200L, NSV40200L

# 40 V, 2.0 A, Low $V_{CE(sat)}$ PNP Transistor

ON Semiconductor's $e^2$PowerEdge family of low $V_{CE(sat)}$ transistors are miniature surface mount devices featuring ultra low saturation voltage ($V_{CE(sat)}$) and high current gain capability. These are designed for use in low voltage, high speed switching applications where affordable efficient energy control is important.

Typical applications are DC−DC converters and power management in portable and battery powered products such as cellular and cordless phones, PDAs, computers, printers, digital cameras and MP3 players. Other applications are low voltage motor controls in mass storage products such as disc drives and tape drives. In the automotive industry they can be used in air bag deployment and in the instrument cluster. The high current gain allows $e^2$PowerEdge devices to be driven directly from PMU's control outputs, and the Linear Gain (Beta) makes them ideal components in analog amplifiers.

### Features

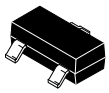
- NSV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC−Q101 Qualified and PPAP Capable
- These Devices are Pb−Free, Halogen Free/BFR Free and are RoHS Compliant*

*For additional information on our Pb−Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

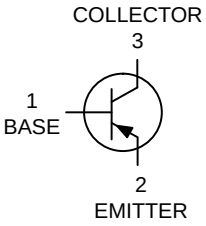
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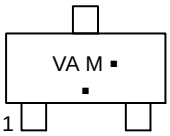
**−40 VOLTS**
**2.0 AMPS**
**PNP LOW $V_{CE(sat)}$ TRANSISTOR**
**EQUIVALENT $R_{DS(on)}$ 80 mΩ**



**SOT−23 (TO−236)**
**CASE 318**
**STYLE 6**




### MARKING DIAGRAM




VA = Specific Device Code*
M = Date Code*
▪ = Pb−Free Package

(Note: Microdot may be in either location)

*Specific Device Code, Date Code or overbar orientation and/or location may vary depending upon manufacturing location. This is a representation only and actual devices may not match this drawing exactly.

### ORDERING INFORMATION

| Device | Package | Shipping† |
|---|---|---|
| NSS40200LT1G | SOT−23 (Pb−Free) | 3,000 / Tape & Reel |
| NSV40200LT1G | SOT−23 (Pb−Free) | 3,000 / Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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**MAXIMUM RATINGS** ($T_A$ = 25°C)

| Rating | Symbol | Max | Unit |
|---|---|---|---|
| Collector-Emitter Voltage | $V_{CEO}$ | −40 | Vdc |
| Collector-Base Voltage | $V_{CBO}$ | −40 | Vdc |
| Emitter-Base Voltage | $V_{EBO}$ | −7.0 | Vdc |
| Collector Current − Continuous | $I_C$ | −2.0 | A |
| Collector Current − Peak | $I_{CM}$ | −4.0 | A |
| Base Current − Peak | $I_{BM}$ | −300 | mA |
| Electrostatic Discharge | ESD | HBM Class 3B<br>MM Class C | |

**THERMAL CHARACTERISTICS**

| Characteristic | Symbol | Max | Unit |
|---|---|---|---|
| Total Device Dissipation<br>$T_A$ = 25°C<br>Derate above 25°C | $P_D$ (Note 1) | <br>460<br>3.7 | <br>mW<br>mW/°C |
| Thermal Resistance,<br>Junction−to−Ambient | $R_{\theta JA}$ (Note 1) | <br>270 | °C/W |
| Total Device Dissipation<br>$T_A$ = 25°C<br>Derate above 25°C | $P_D$ (Note 2) | <br>540<br>4.3 | <br>mW<br>mW/°C |
| Thermal Resistance,<br>Junction−to−Ambient | $R_{\theta JA}$ (Note 2) | <br>230 | °C/W |
| Total Device Dissipation<br>(Single Pulse < 10 sec) | $P_{Dsingle}$<br>(Note 3) | <br>710 | mW |
| Junction and Storage Temperature Range | $T_J$, $T_{stg}$ | −55 to +150 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. FR−4 @ 100 $mm^2$, 1 oz. copper traces.
2. FR−4 @ 500 $mm^2$, 1 oz. copper traces.
3. Thermal response.

**ELECTRICAL CHARACTERISTICS** ($T_A$ = 25°C unless otherwise noted)

| Characteristic | Symbol | Min | Typ | Max | Unit |
|---|---|---|---|---|---|
| **OFF CHARACTERISTICS** | | | | | |
| Collector−Emitter Breakdown Voltage ($I_C$ = −10 mAdc, $I_B$ = 0) | $V_{(BR)CEO}$ | −40 | – | – | Vdc |
| Collector−Base Breakdown Voltage ($I_C$ = −0.1 mAdc, $I_E$ = 0) | $V_{(BR)CBO}$ | −40 | – | – | Vdc |
| Emitter−Base Breakdown Voltage ($I_E$ = −0.1 mAdc, $I_C$ = 0) | $V_{(BR)EBO}$ | −7.0 | – | – | Vdc |
| Collector Cutoff Current ($V_{CB}$ = −40 Vdc, $I_E$ = 0) | $I_{CBO}$ | – | – | −0.1 | μAdc |
| Emitter Cutoff Current ($V_{EB}$ = −7.0 Vdc) | $I_{EBO}$ | – | – | −0.1 | μAdc |
| **ON CHARACTERISTICS** | | | | | |
| DC Current Gain (Note 4)<br>($I_C$ = −10 mA, $V_{CE}$ = −2.0 V)<br>($I_C$ = −500 mA, $V_{CE}$ = −2.0 V)<br>($I_C$ = −1.0 A, $V_{CE}$ = −2.0 V)<br>($I_C$ = −2.0 A, $V_{CE}$ = −2.0 V) | $h_{FE}$ | <br>250<br>220<br>180<br>150 | <br>–<br>300<br>–<br>– | <br>–<br>–<br>–<br>– | |
| Collector−Emitter Saturation Voltage (Note 4)<br>($I_C$ = −0.1 A, $I_B$ = −0.010 A) (Note 5)<br>($I_C$ = −1.0 A, $I_B$ = −0.100 A)<br>($I_C$ = −1.0 A, $I_B$ = −0.010 A)<br>($I_C$ = −2.0 A, $I_B$ = −0.200 A) | $V_{CE(sat)}$ | <br>–<br>–<br>–<br>– | <br>−0.010<br>−0.080<br>−0.135<br>−0.135 | <br>−0.017<br>−0.095<br>−0.170<br>−0.170 | V |
| Base−Emitter Saturation Voltage (Note 4)<br>($I_C$ = −1.0 A, $I_B$ = −0.01 A) | $V_{BE(sat)}$ | – | – | −0.900 | V |
| Base−Emitter Turn−on Voltage (Note 4)<br>($I_C$ = −1.0 A, $V_{CE}$ = −2.0 V) | $V_{BE(on)}$ | – | – | −0.900 | V |
| Cutoff Frequency<br>($I_C$ = −100 mA, $V_{CE}$ = −5.0 V, f = 100 MHz) | $f_T$ | 100 | – | – | MHz |
| Input Capacitance ($V_{EB}$ = 0.5 V, f = 1.0 MHz) | Cibo | – | – | 325 | pF |
| Output Capacitance ($V_{CB}$ = 3.0 V, f = 1.0 MHz) | Cobo | – | – | 62 | pF |
| **SWITCHING CHARACTERISTICS** | | | | | |
| Delay ($V_{CC}$ = −30 V, $I_C$ = 750 mA, $I_{B1}$ = 15 mA) | $t_d$ | – | – | 60 | ns |
| Rise ($V_{CC}$ = −30 V, $I_C$ = 750 mA, $I_{B1}$ = 15 mA) | $t_r$ | – | – | 120 | ns |
| Storage ($V_{CC}$ = −30 V, $I_C$ = 750 mA, $I_{B1}$ = 15 mA) | $t_s$ | – | – | 400 | ns |
| Fall ($V_{CC}$ = −30 V, $I_C$ = 750 mA, $I_{B1}$ = 15 mA) | $t_f$ | – | – | 130 | ns |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulsed Condition: Pulse Width = 300 msec, Duty Cycle ≤ 2%.
5. Guaranteed by design but not tested.

## TYPICAL CHARACTERISTICS

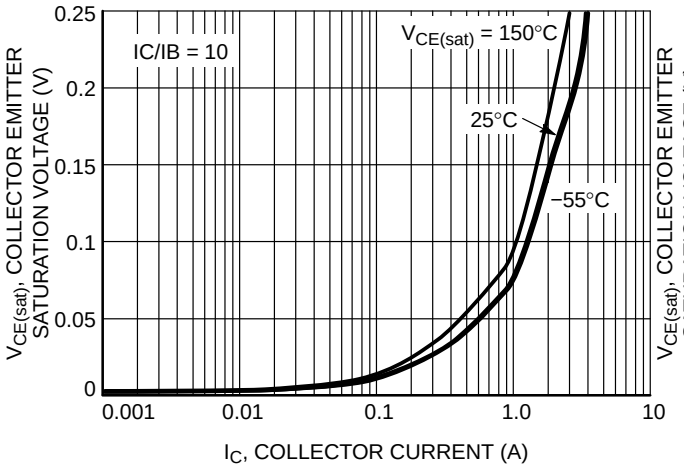



**Figure 1. Collector Emitter Saturation Voltage vs. Collector Current**

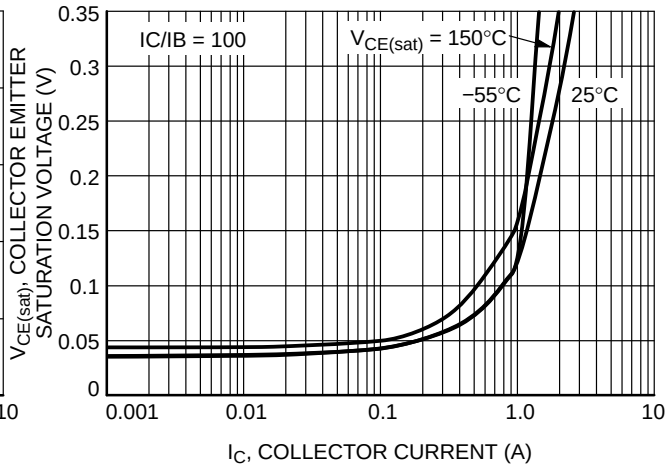



**Figure 2. Collector Emitter Saturation Voltage vs. Collector Current**

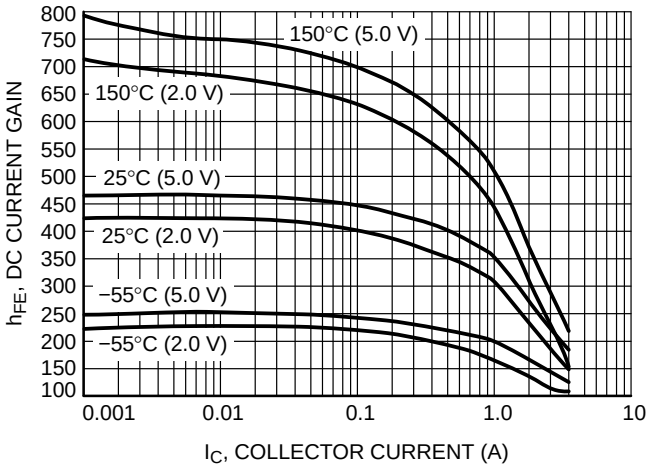



**Figure 3. DC Current Gain vs. Collector Current**

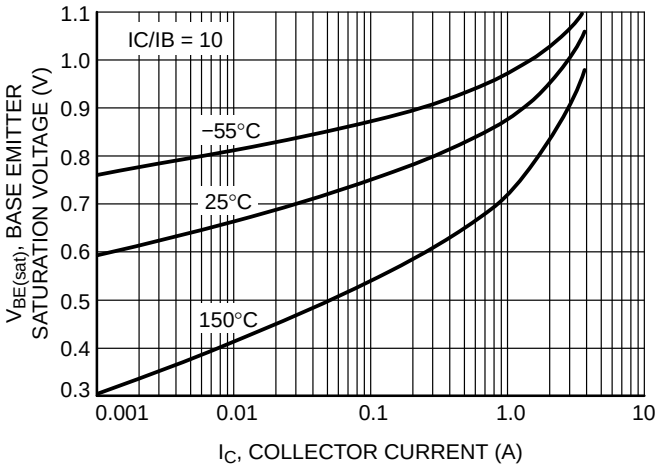



**Figure 4. Base Emitter Saturation Voltage vs. Collector Current**

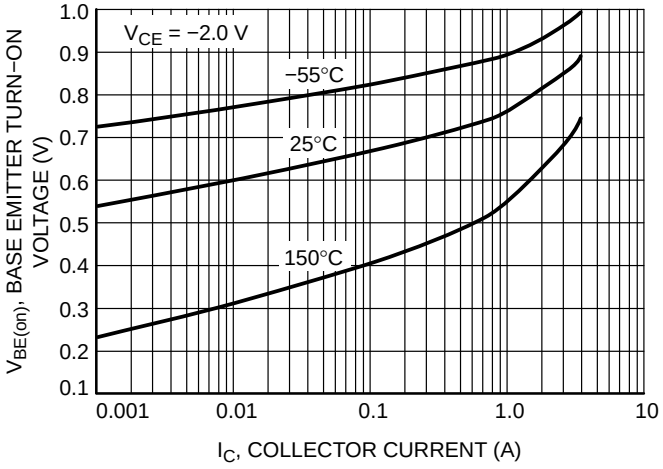



**Figure 5. Base Emitter Turn−On Voltage vs. Collector Current**

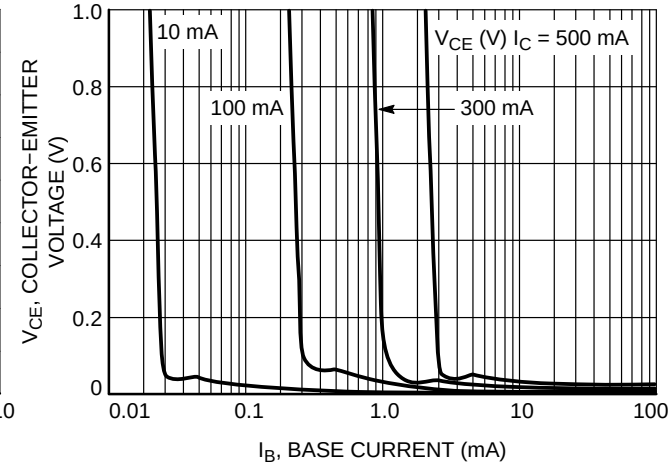



**Figure 6. Saturation Region**

## TYPICAL CHARACTERISTICS

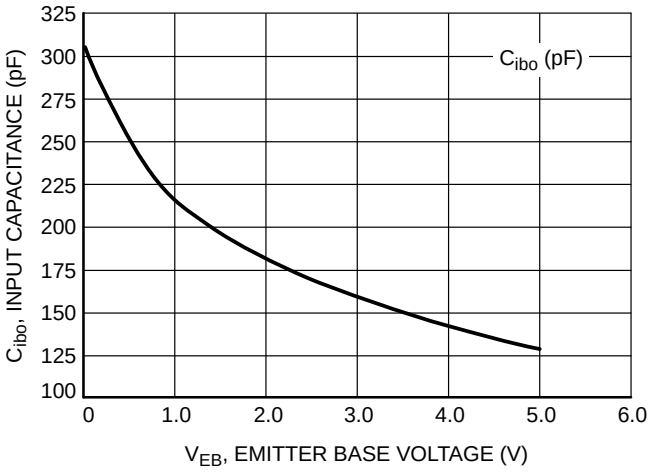



**Figure 7. Input Capacitance**

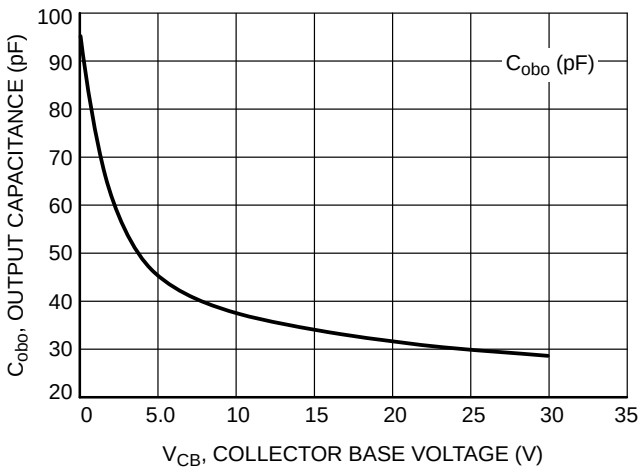



**Figure 8. Output Capacitance**

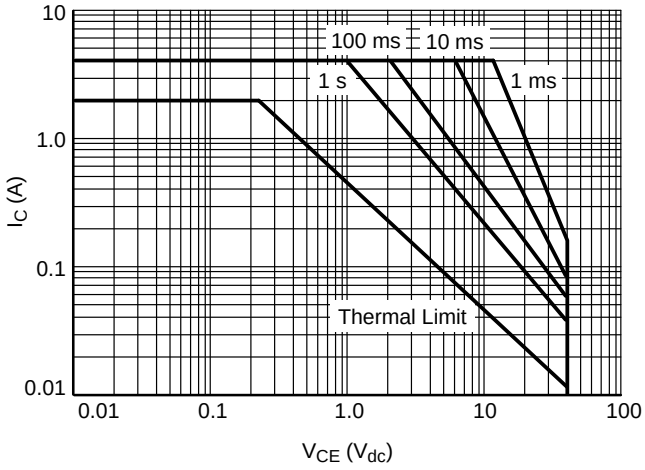
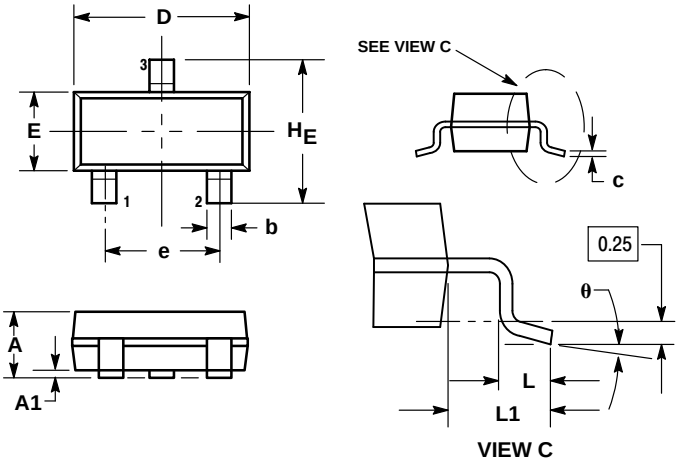



**Figure 9. Safe Operating Area**

## PACKAGE DIMENSIONS

**SOT−23 (TO−236)**
CASE 318−08
ISSUE AP

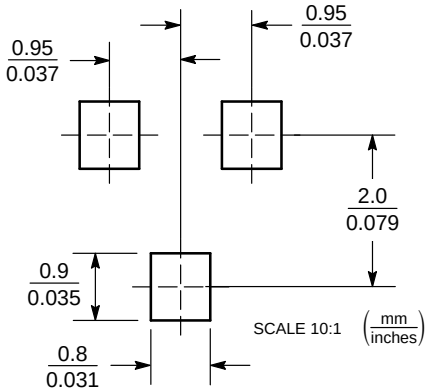



NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

| | MILLIMETERS | | | INCHES | | |
|---|---|---|---|---|---|---|
| DIM | MIN | NOM | MAX | MIN | NOM | MAX |
| A | 0.89 | 1.00 | 1.11 | 0.035 | 0.040 | 0.044 |
| A1 | 0.01 | 0.06 | 0.10 | 0.001 | 0.002 | 0.004 |
| b | 0.37 | 0.44 | 0.50 | 0.015 | 0.018 | 0.020 |
| c | 0.09 | 0.13 | 0.18 | 0.003 | 0.005 | 0.007 |
| D | 2.80 | 2.90 | 3.04 | 0.110 | 0.114 | 0.120 |
| E | 1.20 | 1.30 | 1.40 | 0.047 | 0.051 | 0.055 |
| e | 1.78 | 1.90 | 2.04 | 0.070 | 0.075 | 0.081 |
| L | 0.10 | 0.20 | 0.30 | 0.004 | 0.008 | 0.012 |
| L1 | 0.35 | 0.54 | 0.69 | 0.014 | 0.021 | 0.029 |
| $H_E$ | 2.10 | 2.40 | 2.64 | 0.083 | 0.094 | 0.104 |
| θ | 0° | −−− | 10° | 0° | −−− | 10° |

STYLE 6:
PIN 1. BASE
2. EMITTER
3. COLLECTOR

## SOLDERING FOOTPRINT




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